

Notice of References Cited		Application/Control No. 09/937,522	Applicant(s)/Patent Under Reexamination ICHIOKA ET AL.	
		Examiner John D. Lee	John D. Lee	Art Unit 2874

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,353,149	10-1994	Urakami et al.	359/326
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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